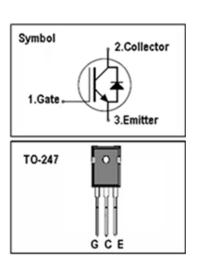
#### **IGBT**

#### **Features**

- 1200V,25A
- $V_{CE(sat)(typ.)}$ =1.8V@ $V_{GE}$ =15V, $I_{C}$ =25A
- High speed switching
- Higher system efficiency
- Soft current turn-off waveforms
- Square RBSOA



JIAEN Trench IGBTs offer lower losses and higher energy efficiency for application such as UPS, Induction converters, Uninterruptible power supplies and other soft switching applications.



#### **Absolute Maximum Ratings**

Symbol	Parameter	Value	Units
V <sub>CES</sub>	Collector-Emitter Voltage	1200	V
V <sub>GES</sub>	Gate-Emitter Voltage	<u>+</u> 30	V
	Continuous Collector Current ( T <sub>C</sub> =25 °C)	50	Α
l <sub>C</sub>	Continuous Collector Current (T <sub>C</sub> =100℃)	25	Α
I <sub>CM</sub>	Pulsed Collector Current (Note 1)	75	Α
I <sub>F</sub>	Diode Continuous Forward Current ( T <sub>C</sub> =100 °C)	25	Α
I <sub>FM</sub>	Diode Maximum Forward Current (Note 1)	75	Α
t <sub>sc</sub>	Short Circuit Withstand Time	10	us
Б	Maximum Power Dissipation ( T <sub>C</sub> =25 ℃)	277	W
P <sub>D</sub>	Maximum Power Dissipation ( T <sub>C</sub> =100 °C)	111	W
TJ	Operating Junction Temperature Range	-40 to +175	$^{\circ}$
T <sub>STG</sub>	Storage Temperature Range	-40 to +175	$^{\circ}$

#### **Thermal Characteristics**

Symbol	Parameter	Max.	Units
$R_{\text{th } j\text{-c}}$	Thermal Resistance, Junction to case for IGBT	0.45	°C/W
R <sub>th j-c</sub>	Thermal Resistance, Junction to case for Diode	1.5	°C/W
R <sub>th j-a</sub>	Thermal Resistance, Junction to Ambient	40	°C/W



## $\underline{\textbf{Electrical Characteristics}} \text{ ( } T_{\text{C}}\text{=}25^{\circ}\!\text{C unless otherwise noted )}$

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
BV <sub>CES</sub>	Collector-Emitter Breakdown Voltage	V <sub>GE</sub> = 0V, I <sub>C</sub> = 1mA	1200	-	-	V
I <sub>CES</sub>	Collector-Emitter Leakage Current	V <sub>CE</sub> = 1200V, V <sub>GE</sub> = 0V	-	-	100	uA
I <sub>GES</sub>	Gate Leakage Current, Forward	$V_{GE} = + 30V, V_{CE} = 0V$	-	-	<u>+</u> 200	nA
V <sub>GE(th)</sub>	Gate Threshold Voltage	V <sub>GE</sub> = V <sub>CE</sub> , I <sub>C</sub> = 1mA	4.4	-	6.4	V
V <sub>CE(sat)</sub>	Collector-Emitter Saturation Voltage	V <sub>GE</sub> =15V, I <sub>C</sub> = 25A	-	1.8	2.3	V
Qg	Total Gate Charge	V <sub>CC</sub> =600V	-	90.4	-	nC
Qge	Gate-Emitter Charge	V <sub>GE</sub> =15V	-	23.6	-	nC
Qgc	Gate-Collector Charge	IC=25A	-	40.2	-	nC
t d(on)	Turn-on Delay Time		-	35	-	ns
t <sub>r</sub>	Turn-on Rise Time	V <sub>cc</sub> =600V	-	50	-	ns
t d(off)	Turn-off Delay Time	V <sub>GE</sub> =15V	-	235	-	ns
t f	Turn-off Fall Time	│l <sub>C</sub> =25A │R <sub>G</sub> =15Ω	-	170	-	ns
Eon	Turn-on Switching Loss	Inductive Load	-	1.27	-	mJ
Eoff	Turn-off Switching Loss	T <sub>C</sub> =25 ℃	-	1.64	-	mJ
Ets	Total Switching Loss		-	2.91	-	mJ
Cies	Input Capacitance	V <sub>CE</sub> =25V	-	2251	-	pF
C <sub>oes</sub>	Output Capacitance	V <sub>GE</sub> =0V	-	68	-	pF
C <sub>res</sub>	Reverse Transfer Capacitance	f = 1MHz	-	13.7	-	pF

#### **Electrical Characteristics of Diode** ( T<sub>C</sub>=25 ℃ unless otherwise noted )

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
V <sub>F</sub>	Diode Forward Voltage	I <sub>F</sub> =25A	-	2.3	3.2	V
trr	Diode Reverse Recovery Time	V <sub>CE</sub> = 600V	-	248	-	ns
Irr	Diode peak Reverse Recovery Current	I <sub>F</sub> = 25A	-	17.5	-	Α
Qrr	Diode Reverse Recovery Charge	dI <sub>F</sub> /dt = 7000A/us	-	1526	-	nC

#### Notes:

1. Repetitive Rating: Pulse width limited by maximum junction temperature

## **Typical Performance Characteristics**

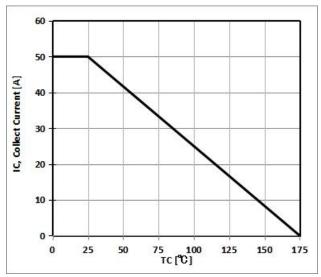
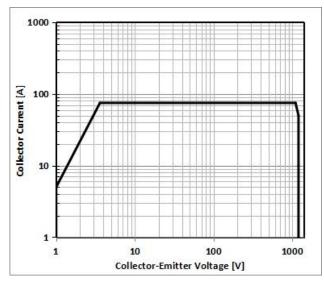


Figure 1: Maximum DC Collector Current VS. case temperature

Figure 2: Power Dissipation VS. Case Temperature



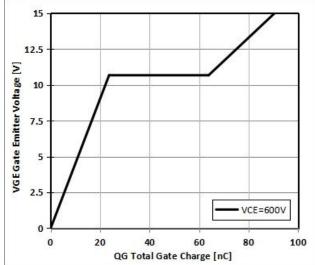


Figure 3: Reverse Bias SOA,TJ=150  $^{\circ}$ C,VGE=15V

Figure 4: Typical Gate charge VS. VGE,IC=25A



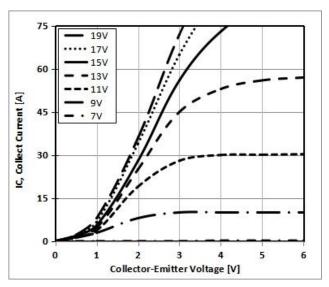


Figure 5: Typical IGBT Output characteristics,  $\label{eq:TC=25\,C;tp=300us} TC = 25\,^{\circ}C; tp = 300us$ 

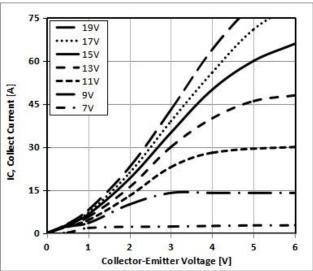


Figure 6: Typical IGBT Output characteristics, TC=150°C;tp=300us

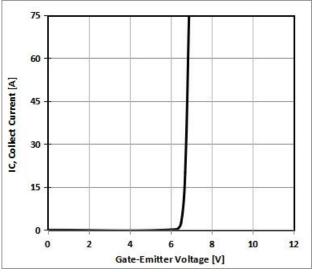


Figure 7: Typical Gate Threshold Voltage

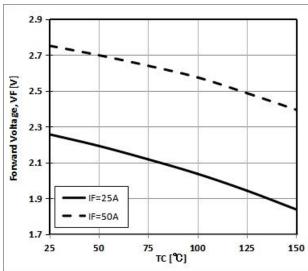


Figure 8: Typical Forward Voltage vs IF



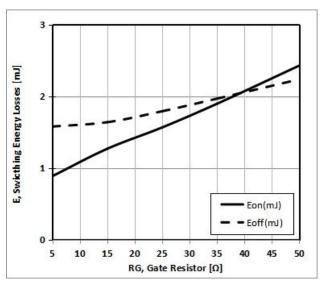


Figure 9: Typical Energy Loss VS. RG, TC=25℃, L=200uH,VCE=600V,VGE=15V,IC=25A

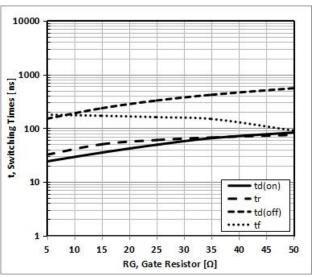


Figure 10: Typical Switching Time VS. RG, TC=25°C, L=200uH,VCE=600V,VGE=15V,IC=25A

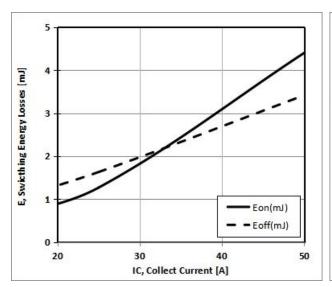


Figure 11: Typical Energy Loss VS. IC,TC=25 $^{\circ}$ C, L=200uH, VCE=600V, VGE=15V,RG=15 $^{\Omega}$ 

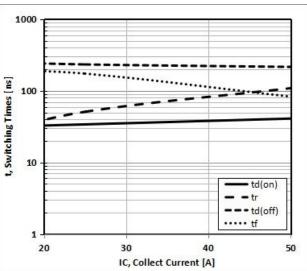


Figure 12: Typical Switching Time VS. IC,TC=25  $^{\circ}\text{C}$  , L=200uH,VCE=600V,VGE=15V,RG=15  $\Omega$ 



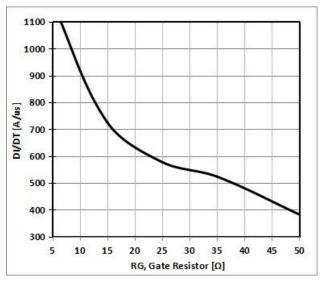


Figure 13: Typical Diode DI/DT VS. RG,TC=25℃ VCC=600V, VGE=15V, IF=25A

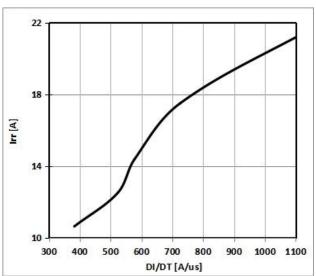


Figure 14: Typical Diode IRR VS. DI/DT,TC=25℃ VCC=600V,VGE=15V, IF=25A

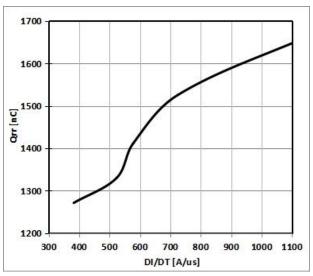


Figure 15: Typical Diode Qrr VS. DI/DT,TC=25  $^{\circ}$ C VCC=600V, VGE=15V, IF=25A

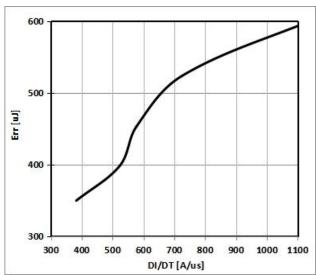


Figure 16: Typical Diode Err VS. DI/DT,TC=25  $^{\circ}$ C VCC=600V, VGE=15V, IF=25A



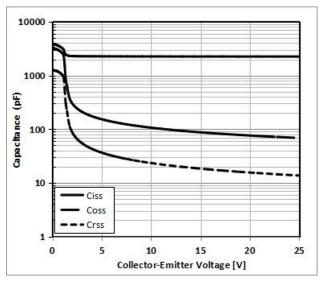


Figure 17: Typical Capacitance VS. VCE, VGE=0V,f=1MHz

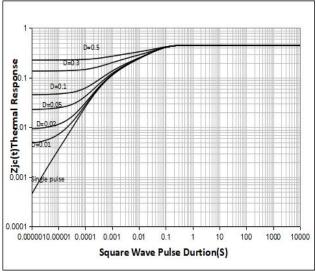
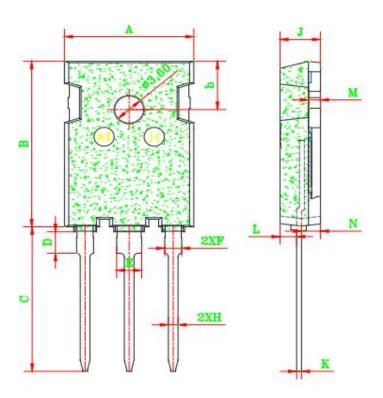


Figure 18: Normalized transient thermal impedance junction-to-case



#### **TO-247 PACKAGE OUTLINE**



	Dimensions				
Ref.	Millimeters				
	Min.	Typ.	Max.		
A	15.70	16.00	16. 30		
b	6. 10	6. 30	6. 20		
В	20.70	21.90	22. 10		
С	18.80	19. 10	19. 40		
D	2.64	2.84	3.04		
Е	2. 90	3. 10	3. 30		
F	1.90	2.10	2.30		
G	5. 25	5. 45	5. 65		
Н	1.10	1, 20	1.30		
J	4. 90	5. 00	5. 10		
K	0.55	0.60	0.65		
L	1.85	2.00	2. 15		
M	1.40	1.50	1.60		
N	2. 10	2. 30	2.50		



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